Application/Control No. Applicant(s)/Patent Under Reexamination 10/659,271 YAGUCHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 John L. Goodrow 1756 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,677,093 01-2004 Yoshino et al. 430/106.2 Hayashi et al. 430/108.3 US-6,130,017 10-2000 В Yaguchi et al. US-2004/0043317 03-2004 430/108.8 C US-D US-E US-F US-G US-H US-US-US-US-L US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name MM-YYYY Country Code-Number-Kind Code JP 2000-319021 いってのり -04-1999 Japan JP 2002-129063 5-2002 -09-2002 Japan 0 Р Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

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